

Search Notes**Application/Control No.**

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Examiner

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**Applicant(s)/Patent under
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GENOV ET AL.

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
708	3, 835	2/21/2008	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	2/21/2008	MAI